

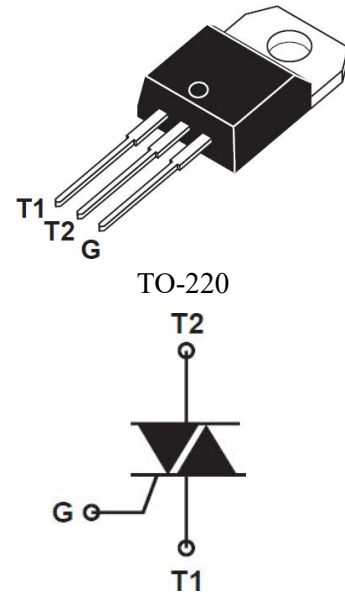
BTA208 TRIACS

●DESCRIPTION:

Due to separation glass passivation, these devices have good performance at dv/dt and reliability. The Triac series is suitable for general purpose AC switching. They can be used as an On-Off function in the applications such as static relays, heating regulation, or for phase control operation in light dimmers, motor speed controllers.

●MAIN FEATURES

Symbol	Value	Unit
$I_{T(RMS)}$	8	A
V_{DRM}/V_{RRM}	600/800	V
I_{GT}	≤ 10	mA



●ABSOLUTE MAXIMUM RATINGS

Symbol	PARAMETER		Value	Unit
$I_{T(RMS)}$	RMS on-state current(full sine wave)	TO-220.Non-Ins $T_c \leq 102^\circ C$	8	A
I_{TSM}	Non repetitive surge peak on-state current (full sine wave, $T_j=25^\circ C$)	$t=20ms$	65	A
		$t=16.7ms$	71	
I^2t	I^2t Value for fusing	$t=10ms$	21	A^2S
di/dt	Repetitive rate of rise of on-state Current after triggering	$I_{TM} = 12 A; I_G = 0.2 A$ $di_G/dt = 0.2 A/us$	100	$A/\mu s$
I_{GM}	Peak gate current	—	2	A
V_{GM}	Peak gate voltage	—	5	W
P_{GM}	Peak gate power	—	5	W
$P_{G(AV)}$	Average gate power	over any 20 ms period	0.5	W
T_{stg}	Storage junction temperature range	-40 to +150		$^\circ C$
T_j	Operating junction temperature range	125		$^\circ C$

● ELECTRICAL CHARACTERISTICS ($T_j = 25^\circ\text{C}$, unless otherwise specified)

STATIC CHARACTERISTICS

Symbol	Parameter	Test Condition	Quadrant	Value			Unit
				MIN	TYPE	MAX	
I_{GT}	Gate trigger current	$V_D=12\text{V}, I_T=0.1\text{A}$	I-II-III	-	-	10	mA
V_{GT}	Gate trigger voltage	$V_D=12\text{V}, I_T=0.1\text{A}$		-	0.7	1.5	V
		$V_D=400\text{V}, I_T=0.1\text{A}, T_j=125^\circ\text{C}$		0.25	0.4	-	
V_T	On-state voltage	$I_T=10\text{A}$		-	1.3	1.65	V
I_H	Holding current	$V_D=12\text{V}, I_{GT}=0.1\text{A}$	I-II-III	-	-	60	mA
I_L	Latching current	$V_D=12\text{V}, I_{GT}=0.1\text{A}$	I-III	-	-	60	mA
			II	-	-	90	mA
I_D	Off-state leakage current	$V_D = V_{DRM(max)}; T_j= 125^\circ\text{C}$		-	0.1	0.5	mA

DYNAMIC CHARACTERISTICS

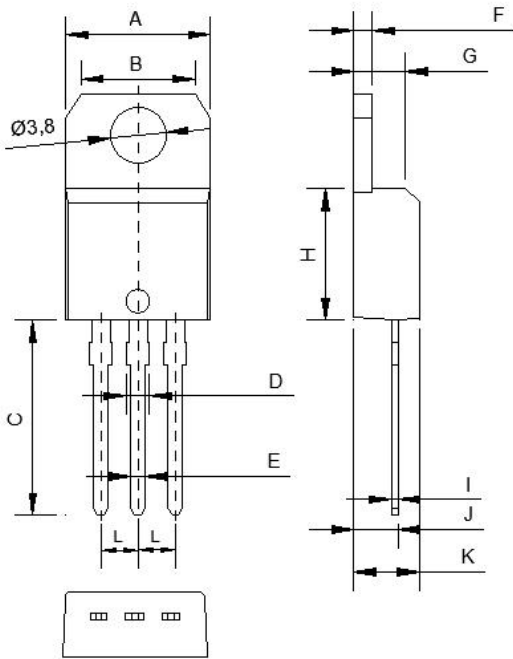
Symbol	Parameter	Test Condition	Value		Unit
			MIN	TYPE	
dV_D/dt	Critical rate of rise of off-state voltage	$V_{DM} = 67\% V_{DRM(max)}; T_j = 125^\circ\text{C}$ exponential waveform; gate open circuit	1000	4000	V/us
dI_{com}/dt	Critical rate of change of commutating current	$V_{DM} = 400\text{V}; T_j = 125^\circ\text{C}; I_{T(RMS)} = 8\text{A};$ without snubber; gate open circuit		14	A/ms
t_{gt}	Gate controlled turn-on time	$I_{TM} = 12\text{A}; V_D = V_{DRM(max)}; I_G = 0.1\text{A}; dI_G/dt = 5\text{A}/\mu\text{s}$		2	us

● THERMAL RESISTANCES

Symbol	Parameter	Test Condition	Value			Unit
			MIN	TYPE	MAX	
$R_{th\ j-mb}$	Thermal resistance junction to mounting base	full cycle			2.0	K/W
		half cycle			4.0	
$R_{th\ j-a}$	Thermal resistance junction to ambient	In free air		60		K/W

PACKAGE MECHANICAL DATA

TO-220



Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	9.80	10.00	0.386	0.394
B	7.70	7.90	0.303	0.311
C	13.15	13.55	0.518	0.533
D	1.51	1.61	0.059	0.063
E	0.96	1.00	0.038	0.039
F	1.20	1.30	0.047	0.051
G	3.40	3.60	0.134	0.142
H	8.80	9.10	0.346	0.358
I	0.42	0.48	0.017	0.019
J	2.80	3.10	0.110	0.122
K	4.20	4.70	0.165	0.185
L	2.50	2.60	0.098	0.102

ELECTRICAL CHARACTERISTICS (CURVES)

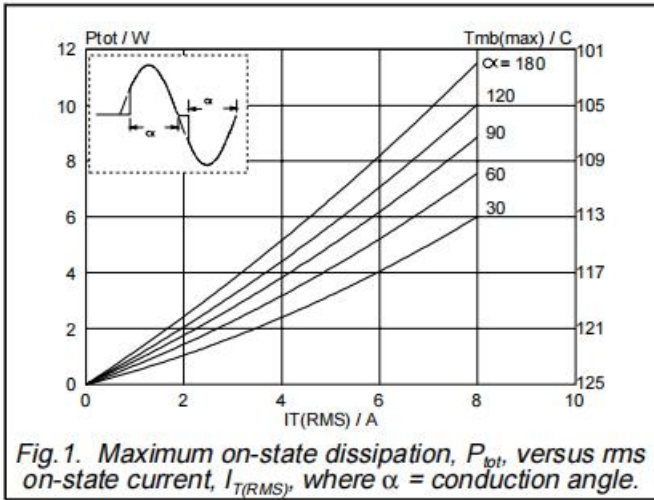


Fig. 1. Maximum on-state dissipation, P_{tot} , versus rms on-state current, $I_{T(RMS)}$, where α = conduction angle.

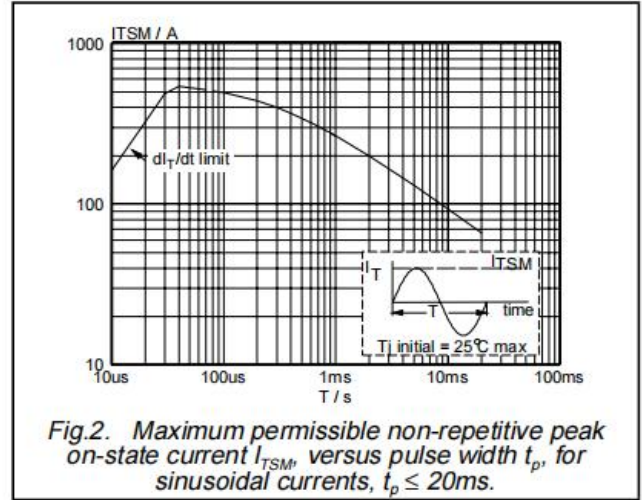


Fig. 2. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus pulse width t_p , for sinusoidal currents, $t_p \leq 20ms$.

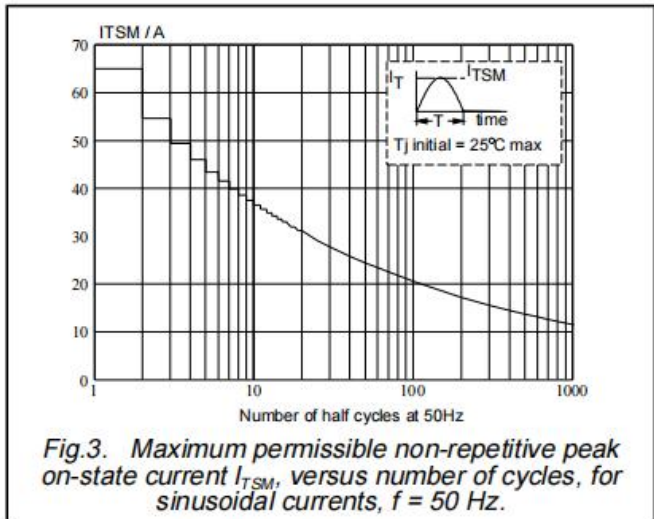


Fig. 3. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus number of cycles, for sinusoidal currents, $f = 50 Hz$.

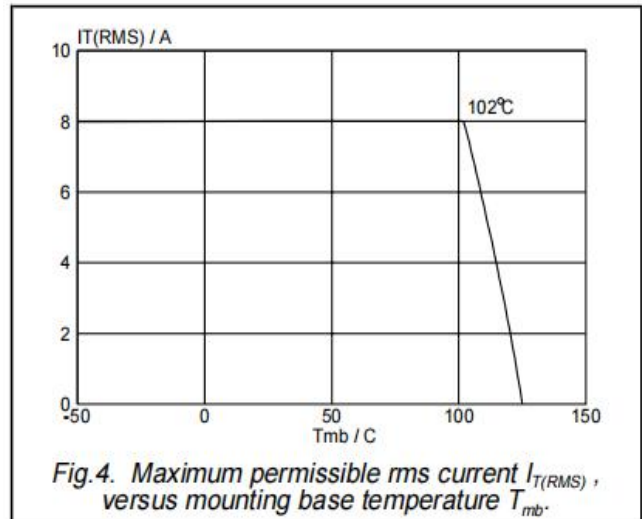


Fig. 4. Maximum permissible rms current $I_{T(RMS)}$, versus mounting base temperature T_{mb} .

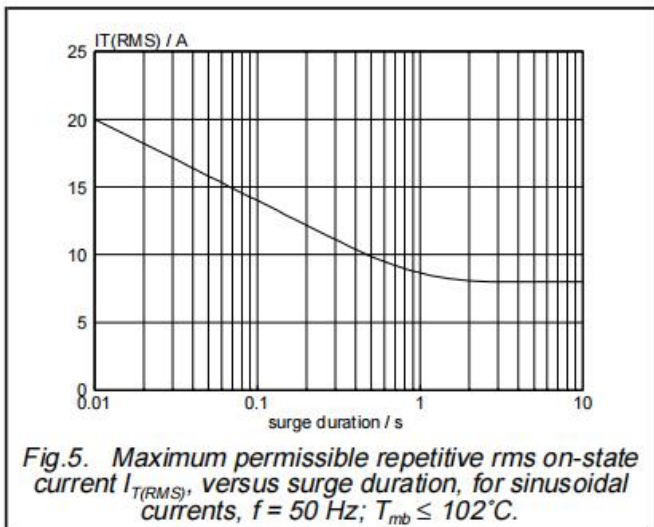


Fig. 5. Maximum permissible repetitive rms on-state current $I_{T(RMS)}$, versus surge duration, for sinusoidal currents, $f = 50 Hz$; $T_{mb} \leq 102^\circ C$.

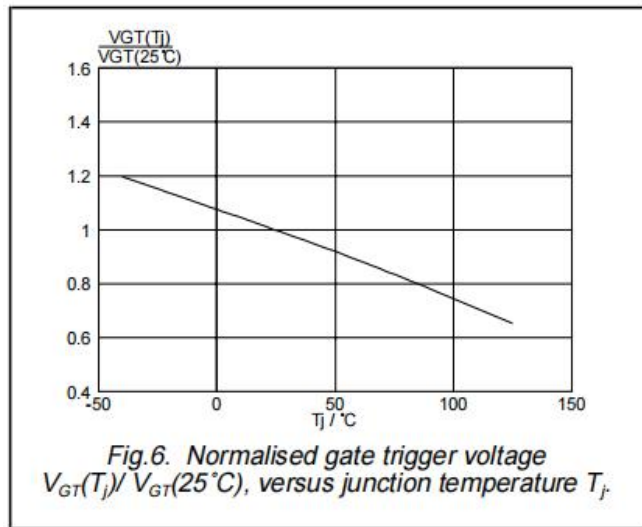


Fig. 6. Normalised gate trigger voltage $V_{GT}(T_j) / V_{GT}(25^\circ C)$, versus junction temperature T_j .

